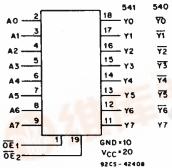
Technical Data

CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541



Data sheet acquired from Harris Semiconductor SCHS285A – Revised November 1999



Octal Buffer/Line Drivers, 3-State

CD74AC/ACT540 - Inverting CD74AC/ACT541 - Non-Inverting

Type Features:

- Buffered inputs
- Typical propagation delay: 4.5 ns @ V_{CC} = 5 V, T_A = 25° C, C_L = 50 pF

FUNCTIONAL DIAGRAM

The CD54/74AC540, -541, and CD54/74ACT540, -541 octal buffer/line drivers use the RCA ADVANCED CMOS technology. The CD54/74AC/ACT540 are inverting 3-state buffers having two active-LOW output enables. The CD54/74AC/ACT541 are non-inverting 3-state buffers having two active-LOW output enables.

The CD74AC540, -541, and CD74ACT540, -541 are supplied in 20-lead dual-in-line plastic packages (E suffix) and in 20-lead dual-in-line small-outline plastic packages (M suffix). Both package types are operable over the following temperature ranges: Industrial (–40 to +85°C) and Extended Industrial/Military (–55 to +125°C).

The CD54AC540, -541, and CD54ACT540, -541, available in chip form (H suffix), are operable over the -55 to +125°C temperature range.

Family Features:

- Exceeds 2-kV ESD Protection MIL-STD-883, Method 3015
- SCR-Latchup-resistant CMOS process and circuit design
- Speed of bipolar FAST®/AS/S with significantly reduced power consumption
- Balanced propagation delays
- AC types feature 1.5-V to 5.5-V operation and balanced noise immunity at 30% of the supply.
- ± 24-mA output drive current
 - Fanout to 15 FAST® ICs
 - Drives 50-ohm transmission lines

®FAST is a Registered Trademark of Fairchild Semiconductor Corp.

TRUTH TABLE

T WILL THE	CD54/74	AC/ACT540
INPUTS		OUTPUTS
OE1, OE2	Α	Y
L	L	Н
Ļ	Н	L
н	X	Z

H = High Voltage

L = Low Voltage

X = Immaterial

Z = High Impedance

TRUTH TABLE

	CD54/74AC/ACT541							
INPUTS		OUTPUTS						
OE1, OE2	A	Y						
Late	L	W.075						
Ł	H W	Н						
Н	X	Z						



Technical Data

CD54/74AC540, CD54/74AC541 CD54/74ACT540, CD54/74ACT541

,	
-VOLTAGE (V _{CC}) –	0.5 to 6 V
DIODE CURRENT, $I_{ K }$ (for $V_{ K } < -0.5$ or $V_{ K } > V_{CC} + 0.5$ V)	. ±20 mA
Γ DIODE CURRENT, I_{OK} (for $V_O < -0.5$ or $V_O > V_{CC} + 0.5$ $V)$	
Γ SOURCE OR SINK CURRENT per Output Pin, IO (for V_O > -0.5 or V_O < V_{CC} + 0.5 V)	. $\pm 50~\text{mA}$
GROUND CURRENT (ICC or IGND)	±100 mA*
HERMAL IMPEDANCE, θ _{JA} (see Note 1): E package	. 69°C/W
M package	. 58°C/W

RECOMMENDED OPERATING CONDITIONS:

MAXIMUM RATINGS. Absolute-Maximum Values:

For maximum reliability, normal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	LIN		
CHARACTERISTIC	MIN.	MAX.	UNITS
Supply-Voltage Range, V _{CC} *: (For T _A = Full Package-Temperature Range)			
AC Types ACT Types	1.5 4.5	5.5 5.5	V
DC Input or Output Voltage, V _i , V _o	0	V _{CC}	V
Operating Temperature, T _A :	-55	+125	°C
Input Rise and Fall Slew Rate, dt/dv at 1.5 V to 3 V (AC Types) at 3.6 V to 5.5 V (AC Types) at 4.5 V to 5.5 V (ACT Types)	0 0	50 20 10	ns/V ns/V

^{*}Unless otherwise specified, all voltages are referenced to ground.

TERMINAL ASSIGNMENT DIAGRAMS



^{*} For up to 4 outputs per device: add ± 25 mA for each additional output.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

Technical Data	
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STATIC ELECTRICAL CHARACTERISTICS: AC Series

			TOOT COMPLETIONS		AMBIENT TEMPERATURE (TA) - °C						
CHARACTERISTICS		TEST CO	TEST CONDITIONS		+:	25	-40 to	o +85	-55 to	+125	UNITS
		V, (V)	l _o (mA)	V _{cc} (V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input				1.5	1.2	_	1.2	_	1.2	_	
Voltage	ViH			3	2.1	_	2.1		2.1] v
				5.5	3.85	-	3.85	_	3.85	_	l
Low-Level Input				1.5	_	0.3	_	0.3		0.3	
Voltage	VIL	:	ļ	3	_	0.9	_	0.9	_	0.9] v
			1	5.5	-	1.65	_	1.65		1.65]
High-Level Output			-0.05	1.5	1.4		1.4	_	1.4	_	
Voltage	V_{OH}	ViH	-0.05	- 3	2.9		2.9		2.9	_	
		or	-0.05	4.5	4.4	_	. 4.4	_	4.4	_]
		VIL	-4	3	2.58	_	2.48		2.4	_] v
			-24	4.5	3.94	_	3.8	_	3.7]
		#, * {	-75	5.5			3.85	_	_	_	
		7, 7	-50	5.5	_				3.85	_]
Low-Level Output		<u> </u>	0.05	1.5	_	0.1	_	0.1	_	0.1	
Voltage	Vol	VIH	0.05	3	_	0.1	_	0.1		0.1]
		or	0.05	4.5	_	0.1		0.1	_	0.1]
		ViL	12	3	_	0.36	_	0.44	_	0.5	V
			24	4.5	_	0.36	_	0.44	_	0.5	
		#, * {	75	5.5	_	_	_	1.65		_	
		! "'	50	5.5			_	_	_	1.65	l
Input Leakage Current	l,	V _{cc} or GND		5.5	_	±0.1	_	±1		±1	μΑ
3-State Leakage		ViH									
Current	loz	or									
		VıL		-			}		1		
		Vo=		5.5	-	±0.5	_	±5		±10	μΑ
		Vcc	İ								
		or						1	ĺ	j 	
		GND					<u> </u>				
Quiescent Supply Current, MSI	loc	V _∞ or GND	0	5.5	_	8	_	80	_	160	μΑ

[#]Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize nower dissination.

power dissipation.

* Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

STATIC ELECTRICAL CHARACTERISTICS: ACT Series

					AMBIEN	TEMPE	RATURE	(T _A) - °(С		
CHARACTERISTICS		TEST CO	NDITIONS	V _{cc}	+:	25	-40 t	o +85	-55 to +125		מדואט
		V, (V)	l _o (mA)	(V)	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
High-Level Input Voltage	V _{IH}			4.5 to 5.5	2	_	2	_	2	_	V
Low-Level Input Voltage	ViL			4.5 to 5.5	_	0.8	_	0.8	_	0.8	v
High-Level Output		V _{IH}	-0.05	4.5	4.4		4.4		4.4		
Voltage	VoH	or V _{IL}	-24	4.5	3.94		3.8		3.7		V
		#, * {	-75	5.5	_		3.85]
			-50	5.5			_		3.85		
Low-Level Output		ViH	0.05	4.5	_	0.1		0.1		0.1	
Voltage	Vol	or V _{IL} #, * {	24	4.5	_	0.36		0.44		0.5	V
			75	5.5			_	1.65]
			50	5.5						1.65	
Input Leakage Current	l ₁	V _{CC} or GND		5.5	_	±0.1	_	±1	-	. ±1	μΑ
3-State Leakage Current	loz	V _{IH} or V _{IL} V _O = V _{CC} or GND		5.5	_	±0.5		±5	-	±10	μΑ
Quiescent Supply Current, MSI	Icc	V _{cc} or GND	0	5.5	_	8	_	80	_	160	μΑ
Additional Quiescent S Current per Input Pi TTL Inputs High 1 Unit Load	Supply n ΔI_{cc}	V _{cc} -2.1		4.5 to 5.5		2.4	_	2.8	_	3	mA

[#]Test one output at a time for a 1-second maximum duration. Measurement is made by forcing current and measuring voltage to minimize power dissipation.

ACT INPUT LOADING TABLE

INPUT	UNIT LOAD*				
	540	541			
DATA	1.42	0.5			
OE1, OE2	1.3	1.3			

*Unit load is ΔI_{CC} limit specified in Static Characteristics Chart, e.g., 2.4 mA max. @ 25° C.

^{*} Test verifies a minimum 50-ohm transmission-line-drive capability at +85°C, 75 ohms at +125°C.

SWITCHING CHARACTERISTICS: AC Series; t,, t, = 3 ns, C, = 50 pF

			AMBI	T			
CHARACTERISTICS	SYMBOL	(v)	-40 t	o +85	-55 to	+125	UNITS
		(*/	MIN.	MAX.	MIN.	MAX.	7
Propagation Delays: Data to Output AC540	t _{PLH}	1.5 3.3* 5†	2.4 1.8	77 8.6 6.2	2.4 1.7	85 9.5 6.8	ns
AC541	t _{PLH} t _{PHL}	1.5 3.3 5	2.8 2.1	89 9.9 7.1	 2.7 2	98 10.9 7.8	ns
Enable, to Output to Output	t _{PZL} t _{PZH}	1.5 3.3 5	4.6 3.1	136 16.4 10.9	4.5 3	150 18 12	ns
Disable to Output to Output	t _{PLZ} t _{PHZ}	1.5 3.3 5	3.9 3.1	136 13.6 10.9	— 3.8 3	150 15 12	ns
Power Dissipation Capacitance AC540 AC541	C _{PD} ‡	-		Тур. 60 Тур. Тур. 60 Тур.			pF
Min. (Valley) V _{OH} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5	4 Typ. @ 25°C			٧	
Max. (Peak) Vol. During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Typ. @ 25°C			٧	
Input Capacitance	Cı	_	_	10	-	10	рF
3-State Output Capacitance	Co	_	-	15	_	15	pF

SWITCHING CHARACTERISTICS: ACT Series; t,, t, = 3 ns, C, = 50 pF

	T		AMBI	۸) - °C	T		
CHARACTERISTICS	SYMBOL	V _{cc}	-40 1	o +85	-55 to	=125	UNITS
		(V)	MIN.	MAX.	MIN.	MAX.]
Propagation Delays: Data to Output ACT540	t _{PLH} t _{PHL}	5†	1.9	6.5	1.8	7.2	ns
ACT541	t _{PLH} t _{PHL}	5†	2.1	7.5	2.1	8.2	ns
Enable to Output	t _{PZL} t _{PZH}	5	3.5	12.2	3.4	13.4	ns
Disable to Output	t _{PLZ} t _{PHZ}	5	3.5	12.2	3.4	13.4	ns
Power Dissipation Capacitance ACT540 ACT541	C _{PO} §	_	1	Тур. Тур.	60 Typ. 60 Typ.		pF
Min. (Valley) V _{OH} During Switching of Other Outputs (Output Under Test Not Switching)	V _{онv} See Fig. 1	5	4 Typ. @ 25°C				. V
Max. (Peak) Vol. During Switching of Other Outputs (Output Under Test Not Switching)	V _{OLP} See Fig. 1	5	1 Typ. @ 25°C			V	
Input Capacitance	Cı		_	10	_	10	pF
3-State Output Capacitance	Co	_	_	15	_	15	pF

*3.3 V: min. is @ 3.6 V max. is @ 3 V

 C_{PD} is used to determine the dynamic power consumption, per channel. For AC series, $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$ For ACT series, $P_D = V_{CC}^2 f_i (C_{PD} + C_L) + V_{CC} \Delta I_{CC}$ where $f_i = input free$

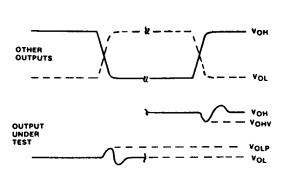
†5 V: min. is @ 5.5 V

 $\begin{aligned} & \textbf{f}_i = \text{input frequency} \\ & \textbf{C}_L = \text{output load capacitance} \end{aligned}$

max. is @ 4.5 V

 V_{cc} = supply voltage.

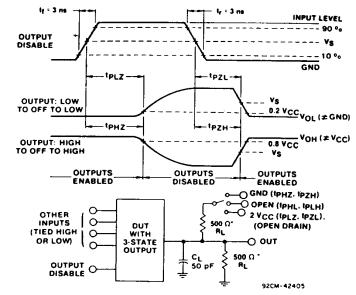
PARAMETER MEASUREMENT INFORMATION



NOTES:

- Vohy and volp are measured with respect to a ground reference near the output under test.
 Input pulses have the following characteristics:
- PRR \leq 1 MHz, t_f = 3 ne, t_f = 3 ne, SKEW 1 ne. 3. R.F. FIXTURE WITH 700-MHz DESIGN RULES REQUIRED. IC SHOULD BE SOLDERED INTO TEST BOARD AND BYPASSED WITH 0.1 JF CAPACITOR. SCOPE AND PROBES REQUIRE 700-MHz BANDWIDTH.

9205-42406



*FOR AC SERIES ONLY: WHEN VCC = 1.5 V, RL = 1 k Ω

Fig. 1 - Simultaneous switching transient waveforms.

Fig. 2 - Three-state propagation delay waveforms and test circuit.

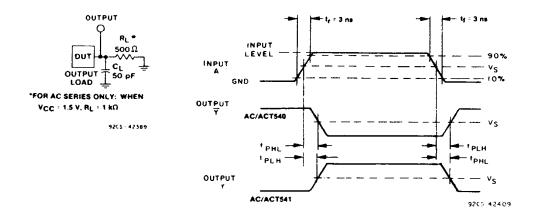


Fig. 3 - Propagation delay times and test circuit.

	CD54/74AC	CD54/74ACT
Input Level	V _{cc}	3 V
Input Switching Voltage, Vs	0.5 V _{cc}	1.5 V
Output Switching Voltage, V ₅	0.5 V _{cc}	0.5 V _{cc}





12-Jan-2006

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CD54AC541F3A	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
CD54ACT540F3A	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
CD54ACT541F3A	ACTIVE	CDIP	J	20	1	TBD	Call TI	N / A for Pkg Type
CD74AC540M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC540ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC541EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74AC541M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541SM	OBSOLETE	SSOP	DB	20		Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541SM96	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74AC541SM96E4	ACTIVE	SSOP	DB	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT540E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74ACT540M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT540M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT540M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT540ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT541E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74ACT541EE4	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type
CD74ACT541M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT541M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT541M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT541ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CD74ACT541SM	OBSOLETE	SSOP	DB	20		TBD	Call TI	Call TI
CD74ACT541SM96	ACTIVE	SSOP	DB	20	2000	Green (RoHS &	CU NIPDAU	Level-1-260C-UNLIM



PACKAGE OPTION ADDENDUM

12-Jan-2006

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Packa Qty	ge Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
					no Sb/Br)		
CD74ACT541SM96E4	ACTIVE	SSOP	DB	20 200	Green (RoHS & no Sb/Br)	& CU NIPDAU	Level-1-260C-UNLIM

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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14 LEADS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

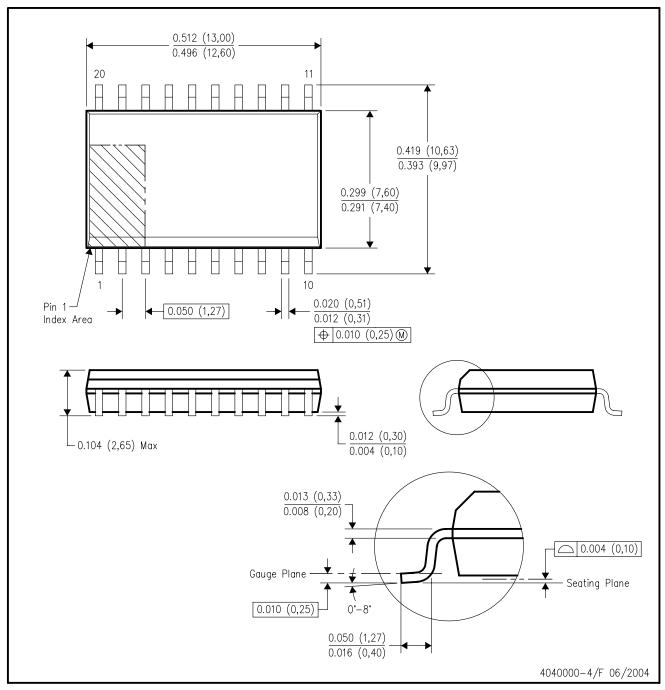


NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.

DW (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

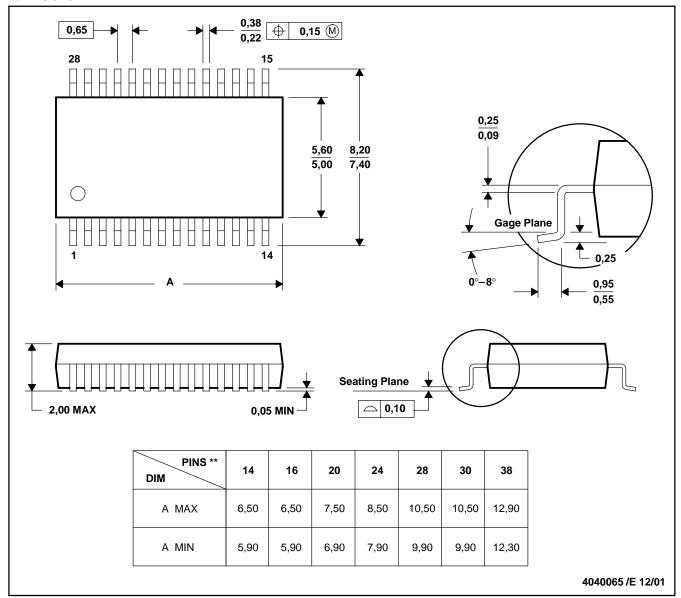
- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AC.



DB (R-PDSO-G**)

PLASTIC SMALL-OUTLINE

28 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-150



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Microcontrollers microcontroller.ti.com		Security	www.ti.com/security
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Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265